Notice of References Cited Application/Control No. 10/730,468 Examiner In Suk Bullock Applicant(s)/Patent Under Reexamination CHEN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,166,283	12-2000	Bharadwaj et al.	585/658
	В	US-6,395,944	05-2002	Griffiths et al.	585/324
	С	US-6,417,422	07-2002	Liu, Yumin	585/658
	D	US-6,566,573	05-2003	Bharadwaj et al.	585/658
	Е	US-4,751,336	06-1988	Jezl et al.	585/324
	F	US-4,754,091	06-1988	Jezl et al.	585/322
	G	US-4,754,093	06-1988	Jezl et al.	585/500
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν					
	0					
	Р					
	α					
	R		*			
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	Ų	
	>	
	W	
	х	

^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.